

Aliases (C0805C274K3NAC7800) SMD Comm X8L HT150C, Ceramic, 0.27 uF, 10%, 25 VDC, X8L, SMD, MLCC, High Temperature, Temperature Stable, 0805, 0.7 mm



General Information	
Series	SMD Comm X8L HT150C
Style	SMD Chip
Description	SMD, MLCC, High Temperature, Temperature Stable
Features	High Temperature, Temperature Stable
RoHS	Yes
Termination	Tin
Marking	No
AEC-Q200	No
Typical Component Weight	13 mg
Shelf Life	78 Weeks
MSL	1

0.27 uF

3% Loss/Decade Hour: Referee Time is 1000 Hours

1.8519 GOhms

Dimensions	
Chip Size	0805
L	2mm +/-0.2mm
W	1.25mm +/-0.2mm
Т	0.9mm +/-0.10mm
S	0.7mm MIN
В	0.5mm +/-0.25mm

n	Measurement Condition	1 kHz 1.0Vrms
mm	Tolerance	10%
mm	Voltage DC	25 VDC
	Dielectric Withstanding Voltage	62.5 VDC
imm	Temperature Range	-55/+150°C
	Temp. Coefficient	X8L
	Capacitance Change with	+15%/-40%, 1kHz 1.0Vrms
aper Tape	Reference to +25°C and 0 VDC Applied (TCC)	
	Dissipation Factor	2.5% 1 kHz 1.0Vrms

**Specifications** 

Capacitance

Aging Rate

Insulation Resistance

Packaging Specifications	
Packaging	T&R, 180mm, Paper Tape
Packaging Quantity	4000

Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and
we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the
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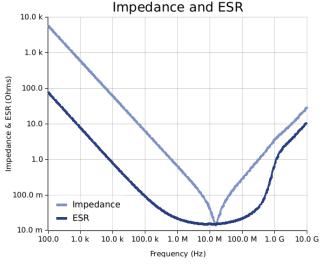
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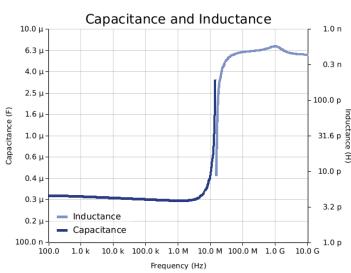


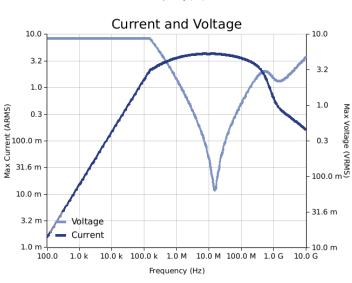
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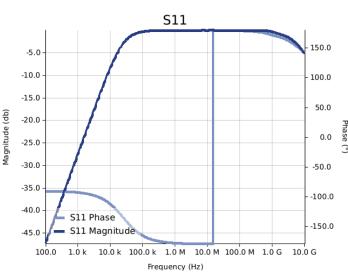
#### **Simulations**

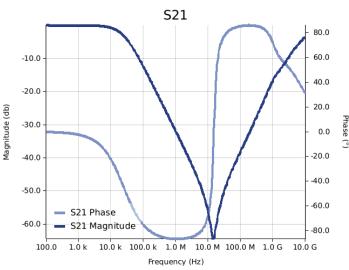
For the complete simulation environment please visit K-SIM.

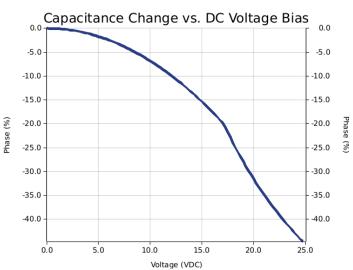








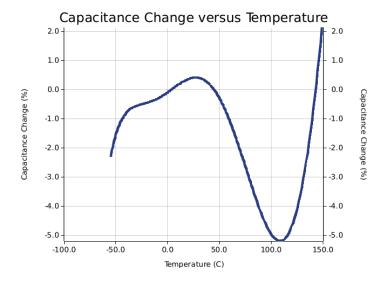


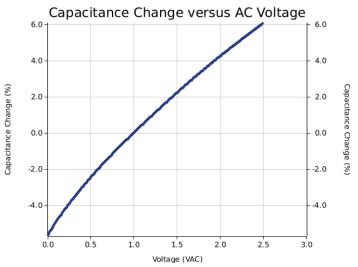


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#### These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.

- The ESR in the "Temperature Rise vs. Ripple Current" plots is adjusted to each incremental temperature rise before the power and ripple current is calculated. The effects shown herein are based on measured data from a multiple part sample of the parts in question.

  Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

  The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages
- generated at any other harmonics.

  Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

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If you have any questions please contact K-SIM.

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